# UNISONIC TECHNOLOGIES CO., LTD

2SD1802

# NPN SILICON TRANSISTOR

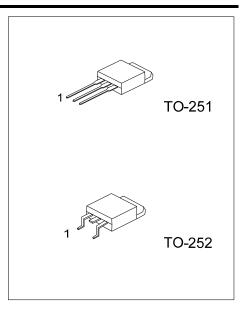
# HIGH CURRENT SWITCHING **APPLICATION**

#### DESCRIPTION

The UTC 2SD1802 applies to voltage regulators, relay drivers, lamp drivers and electrical equipment.

#### **FEATURES**

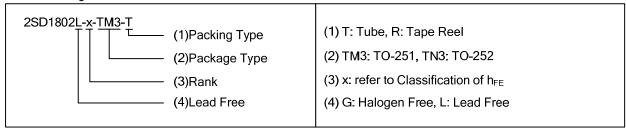
- \* Adoption of FBET, MBIT processes
- \* Large current capacity and wide ASO
- \* Low collector-to-emitter saturation voltage
- \* Fast switching speed



# **ORDERING INFORMATION**

| Ordering         | Daakasa          | Pin Assignment |   |   | Dooking |           |
|------------------|------------------|----------------|---|---|---------|-----------|
| Lead Free        | Halogen Free     | Package        | 1 | 2 | 3       | Packing   |
| 2SD1802L-x-TM3-T | 2SD1802G-x-TM3-T | TO-251         | В | С | Е       | Tube      |
| 2SD1802L-x-TN3-T | 2SD1802G-x-TN3-T | TO-252         | В | С | Е       | Tube      |
| 2SD1802L-x-TN3-R | 2SD1802G-x-TN3-R | TO-252         | В | С | Е       | Tape Reel |

Note: Pin Assignment: B: Base C: Collector E: Emitter



www.unisonic.com.tw 1 of 3 QW-R209-001.Ba

# ■ **ABSOLUTE MAXIMUM RATING** (T<sub>A</sub>= 25°C, unless otherwise specified)

| PARAMETER                   | SYMBOL           | RATINGS            | UNIT                 |
|-----------------------------|------------------|--------------------|----------------------|
| Collector-Base Voltage      | $V_{CBO}$        | 60                 | V                    |
| Collector-Emitter Voltage   | $V_{CEO}$        | 50                 | V                    |
| Emitter-Base Voltage        | $V_{EBO}$        | 6                  | V                    |
| Collector Power Dissipation |                  | 1                  | 10/                  |
| T <sub>C</sub> =25°ℂ        | P <sub>c</sub>   | 15                 | W                    |
| Collector Current (DC)      | Ic               | 3                  | Α                    |
| Collector Current (PULSE)   | I <sub>CP</sub>  | 6                  | Α                    |
| Junction Temperature        | TJ               | 150                | $^{\circ}\mathbb{C}$ |
| Storage Temperature         | T <sub>STG</sub> | -55 ~ <b>+</b> 150 | °C                   |

Note 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

# ■ **ELECTRICAL CHARACTERISTICS** (T<sub>A</sub>=25°C, unless otherwise specified)

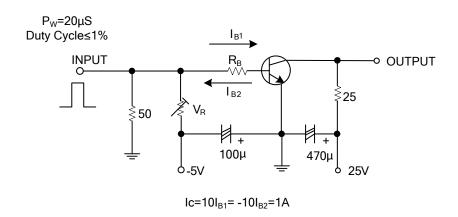
| PARAMETER                | SYMBOL               | TEST CONDITIONS                            | MIN | TYP  | MAX | UNIT |
|--------------------------|----------------------|--|-----|------|-----|------|
| Collector Cutoff Current | I <sub>CBO</sub>     | V <sub>CB</sub> =40V, I <sub>E</sub> =0    |     |      | 1   | μΑ   |
| Emitter Cutoff Current   | I <sub>EBO</sub>     | $V_{EB}$ =4V, $I_C$ =0                     |     |      | 1   | μΑ   |
| DC Current Cain (note)   | h <sub>FE1</sub>     | V <sub>CE</sub> =2V, I <sub>C</sub> =100mA | 100 |      | 560 |      |
| DC Current Gain (note)   | h <sub>FE2</sub>     | $V_{CE}$ =2V, $I_{C}$ =3A                  | 35  |      |     |      |
| Gain-Bandwidth Product   | f <sub>T</sub>       | V <sub>CE</sub> =10V, I <sub>C</sub> =50mA |     | 150  |     | MHz  |
| Output Capacitance       | Сов                  | V <sub>CB</sub> =10V, f=1MHz               |     | 25   |     | pF   |
| C-E Saturation Voltage   | $V_{CE(SAT)}$        | I <sub>C</sub> = 2A, I <sub>B</sub> =100mA |     | 0.19 | 0.5 | V    |
| B-E Saturation Voltage   | V <sub>BE(SAT)</sub> | I <sub>C</sub> = 2A, I <sub>B</sub> =100mA |     | 0.94 | 1.2 | V    |
| C-B Breakdown Voltage    | V <sub>(BR)CBO</sub> | $I_C = 10 \mu A, I_E = 0$                  | 60  |      |     | V    |
| C-E Breakdown Voltage    | $V_{(BR)CEO}$        | I <sub>C</sub> = 1mA, R <sub>BE</sub> =∞   | 50  |      |     | V    |
| E-B Breakdown Voltage    | $V_{(BR)EBO}$        | I <sub>E</sub> = 10μA, I <sub>C</sub> =0   | 6   |      |     | V    |
| Turn-on Time             | ton                  | See test circuit                           |     | 70   |     | ns   |
| Storage Time             | t <sub>STG</sub>     | See test circuit                           |     | 650  |     | ns   |
| Fall Time                | t <sub>F</sub>       | See test circuit                           |     | 35   |     | ns   |

# CLASSIFICATION OF h<sub>FE1</sub>

| RANK  | R       | S       | Т       | U       |  |
|-------|---------|---------|---------|---------|--|
| RANGE | 100-200 | 140-280 | 200-400 | 280-560 |  |

<sup>2.</sup> The device is guaranteed to meet performance specification within  $0^{\circ}$ C  $\sim$ 70 $^{\circ}$ C operating temperature range and assured by design from  $-20^{\circ}$ C  $\sim$ 85 $^{\circ}$ C.

■ **TEST CIRCUIT** (Unit : resistance : Ω, capacitance : F)



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